

# UV Fluorescence from Integrating Spheres Measurement and Theory

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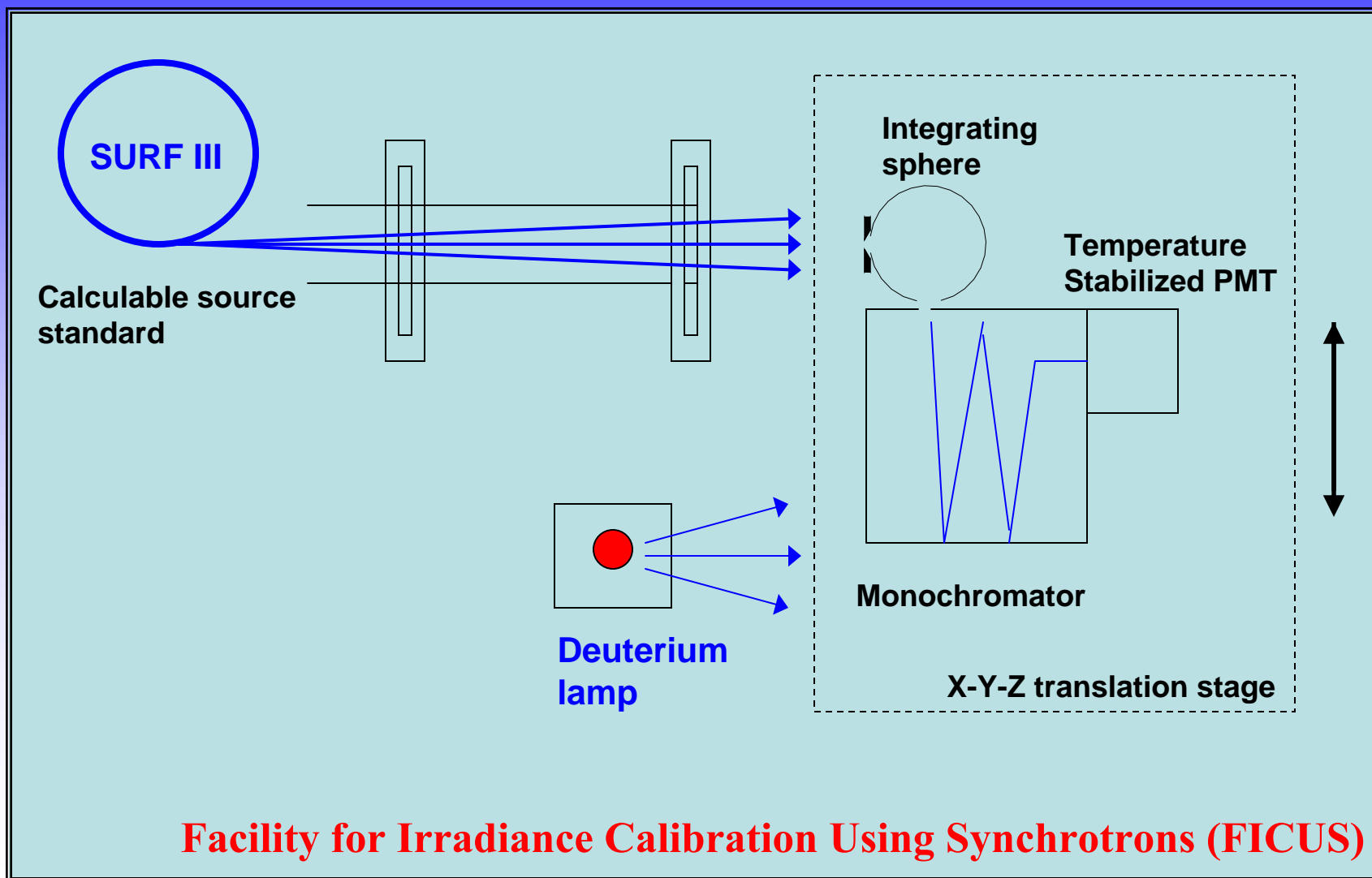
**NIST**

## Outline:

1. UV fluorescence measurement using lasers.
2. Determination of the total spectral fluorescence yield of an integrating sphere.
3. Theory of fluorescence from an integrating sphere.

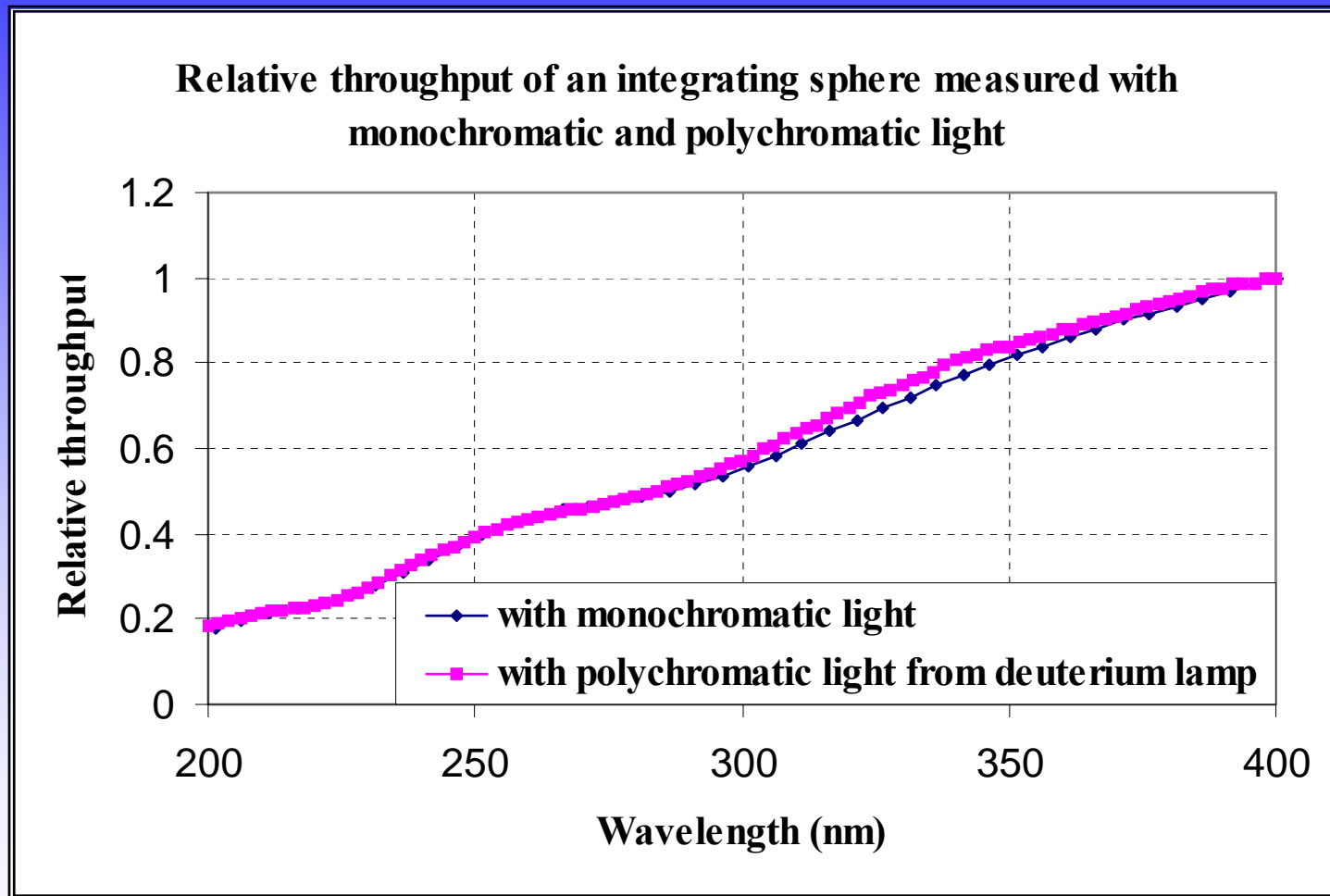
# Integrating Sphere for UV Application

- irradiance calibration of deuterium lamps using synchrotron radiation at NIST



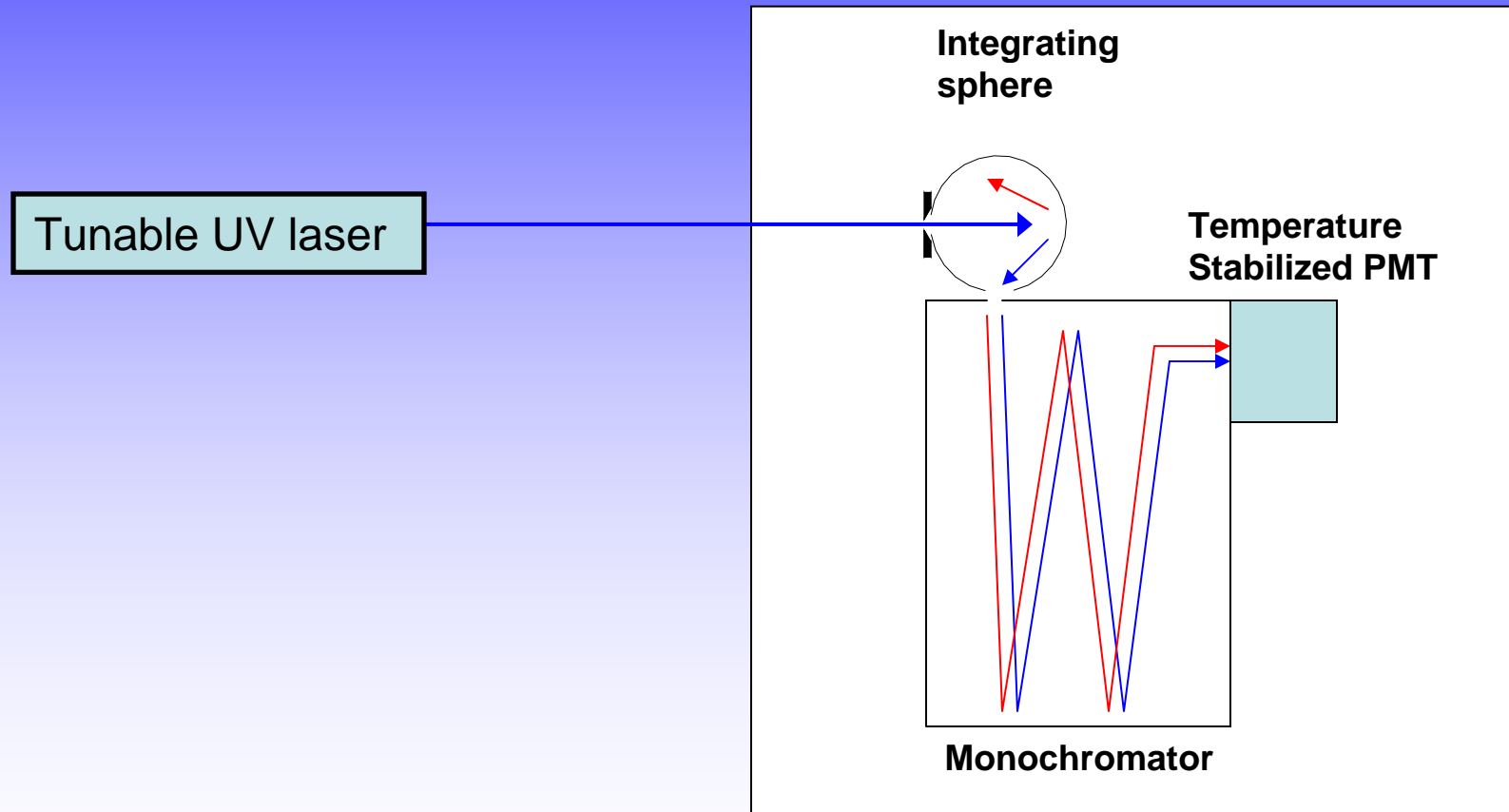
**Facility for Irradiance Calibration Using Synchrotrons (FICUS)**

# Problem with integrating sphere in the UV - fluorescence

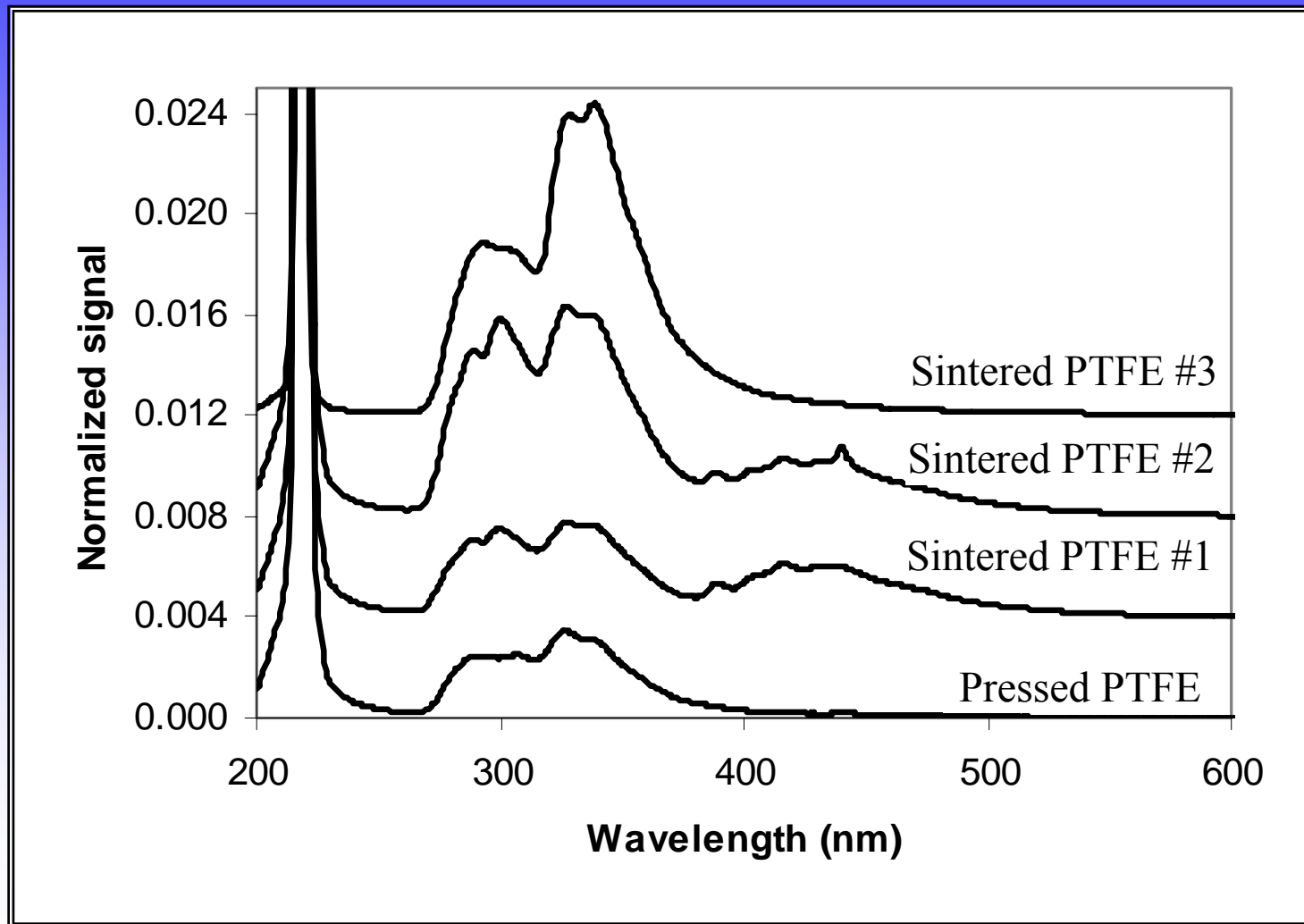


# UV Characterization of integrating spheres

## Laser Induced Fluorescence (LIF)



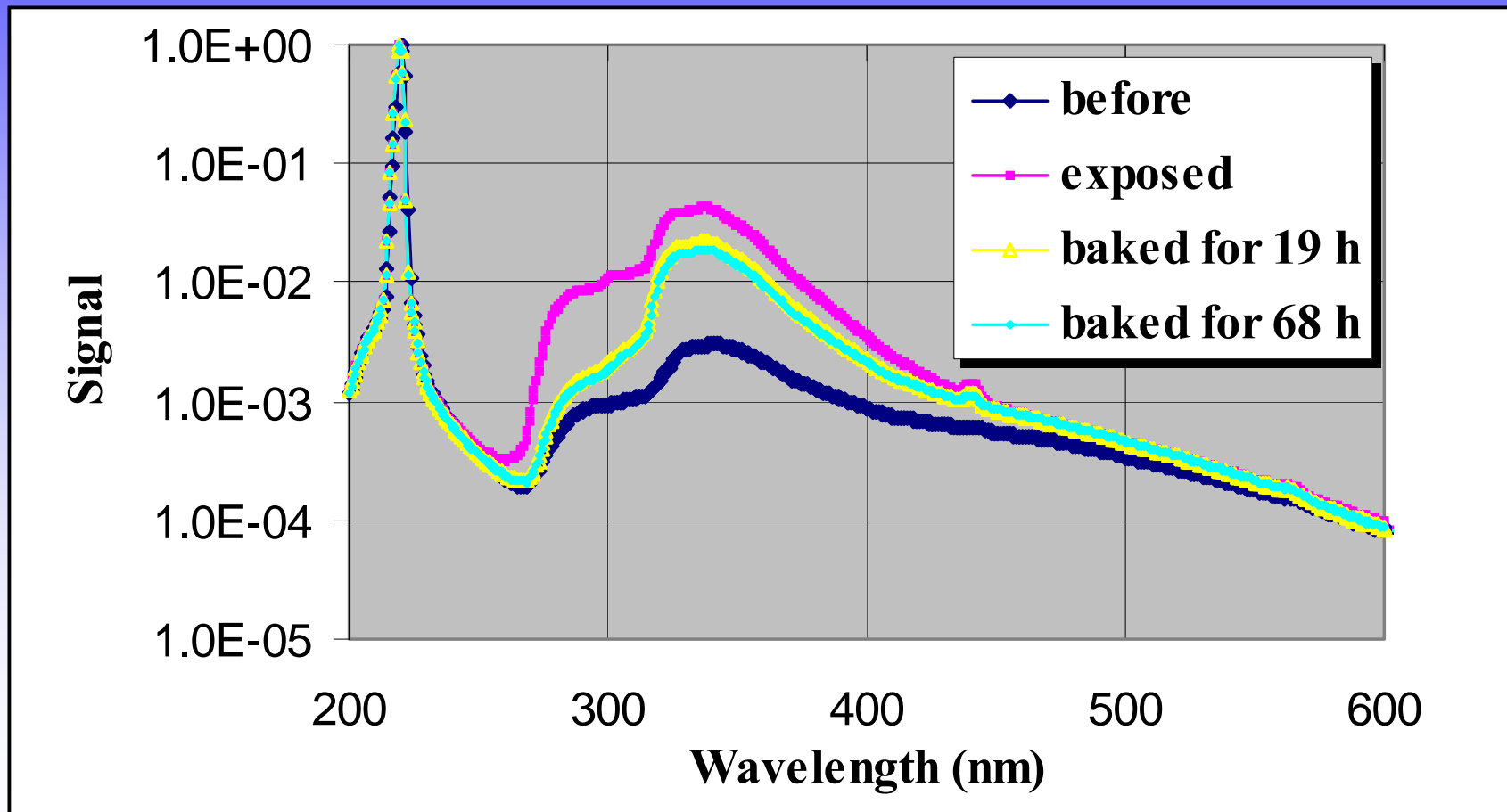
# UV induced fluorescence from typical PTFE integrating spheres excited by 220 nm laser





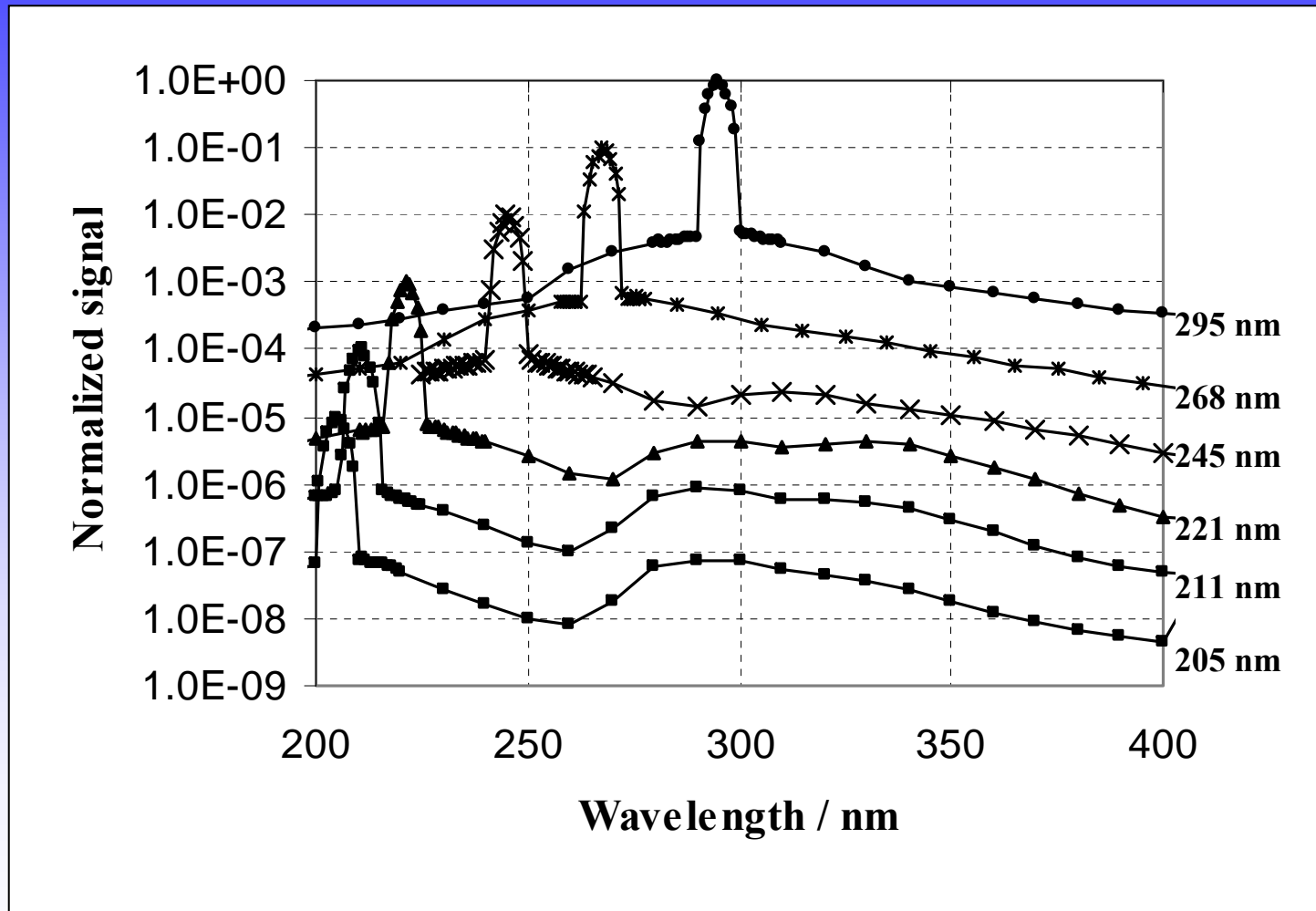
# Sintered PTFE integrating spheres exposed to diesel gas exhaust

## With 220nm excitation laser





# Raw data from laser induced fluorescence measurement of integrating sphere



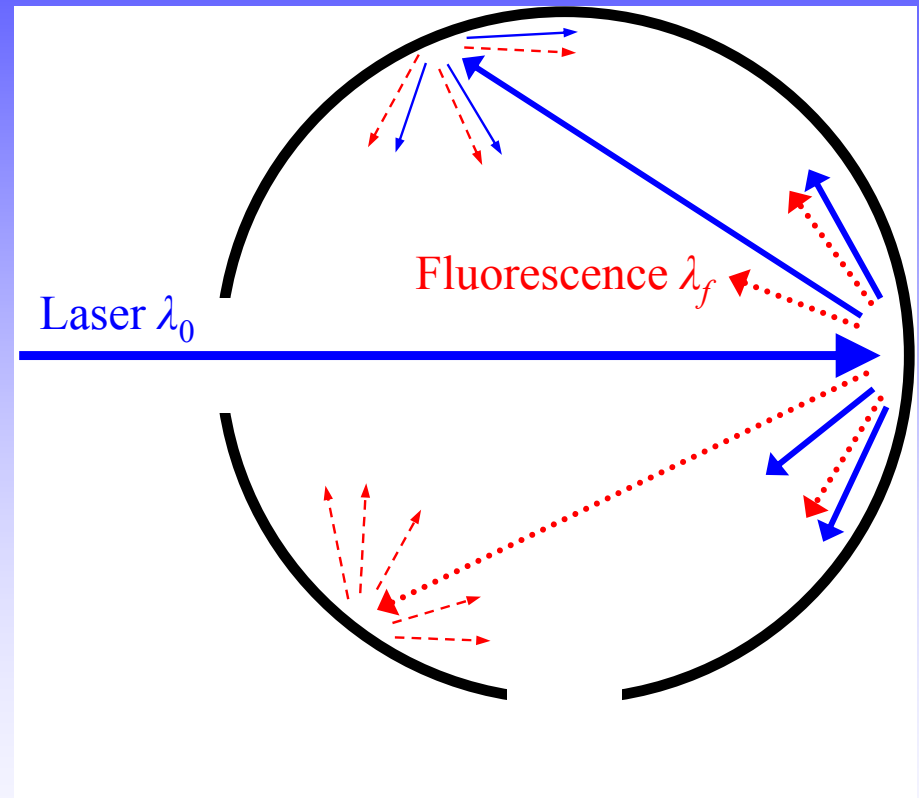
# The total spectral fluorescence yield

Define the total spectral fluorescence yield of an integrating sphere as

$$f_{\lambda, total}(\lambda_f, \lambda_0) = \frac{\Phi_{\lambda, fl}(\lambda_f, \lambda_0)}{\Phi^0}$$

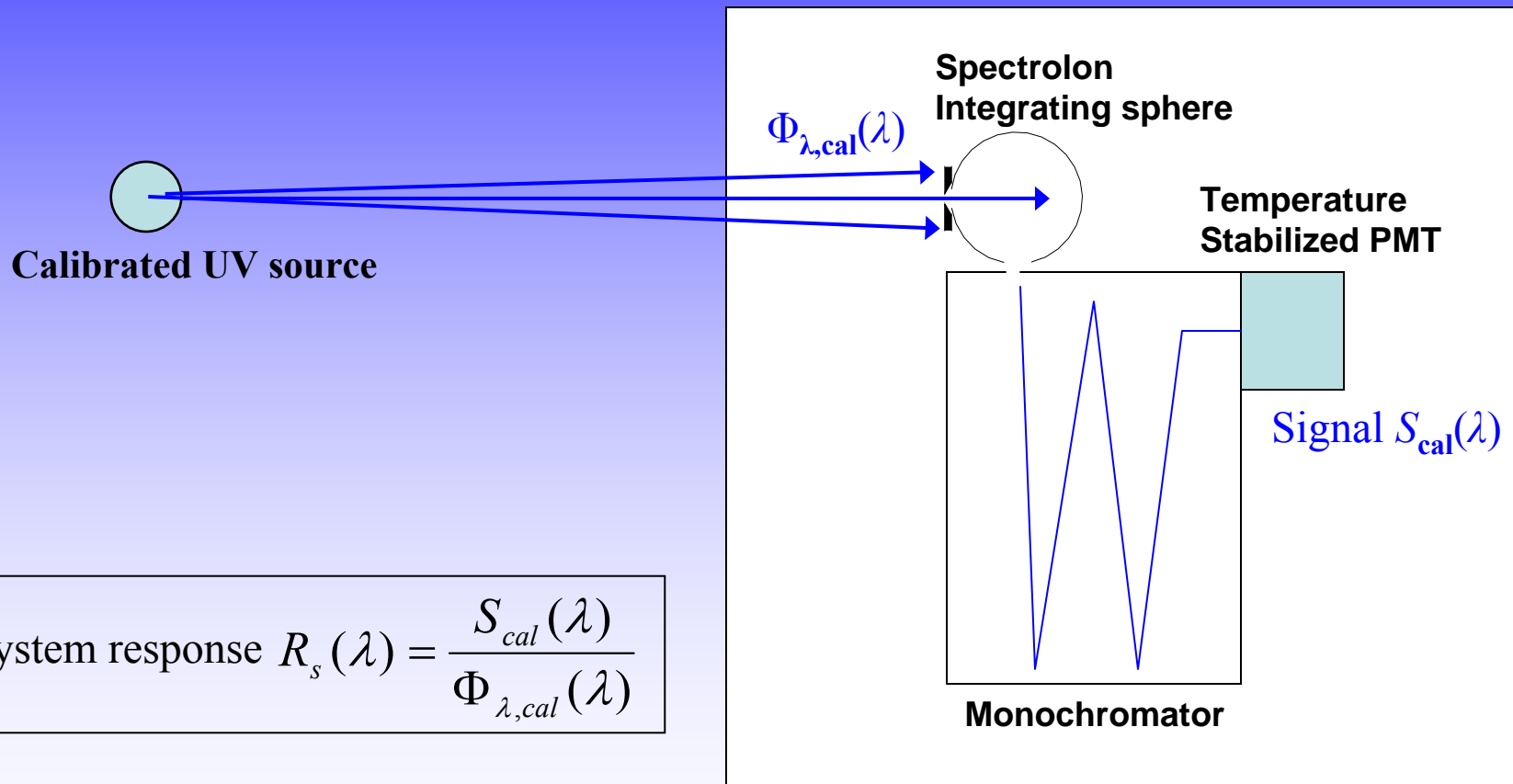
$\Phi^0$  : power of the primary radiation  $\lambda_0$  entering the integrating sphere.

$\Phi_{\lambda, fl}(\lambda_f, \lambda_0)$  : the total spectral power of fluorescence excited.



# Measuring total spectral fluorescence yield

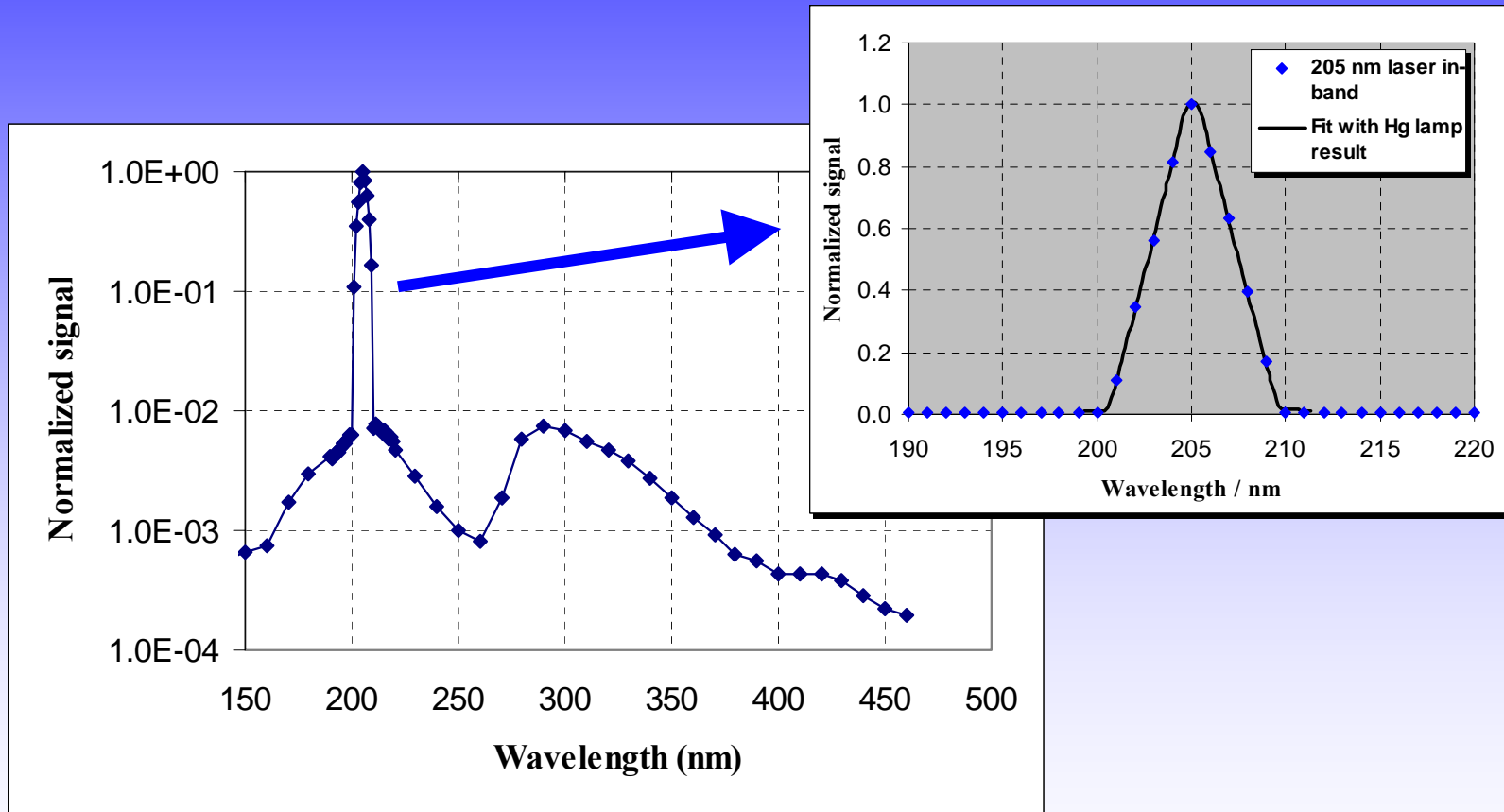
## 1. System response calibration



$$\text{System response } R_s(\lambda) = \frac{S_{cal}(\lambda)}{\Phi_{\lambda,cal}(\lambda)}$$

# Measuring total spectral fluorescence yield

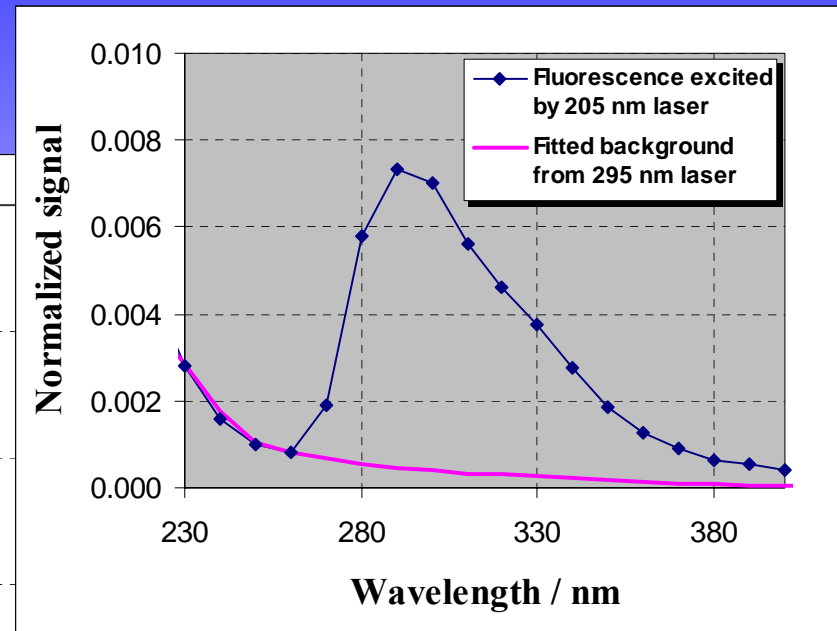
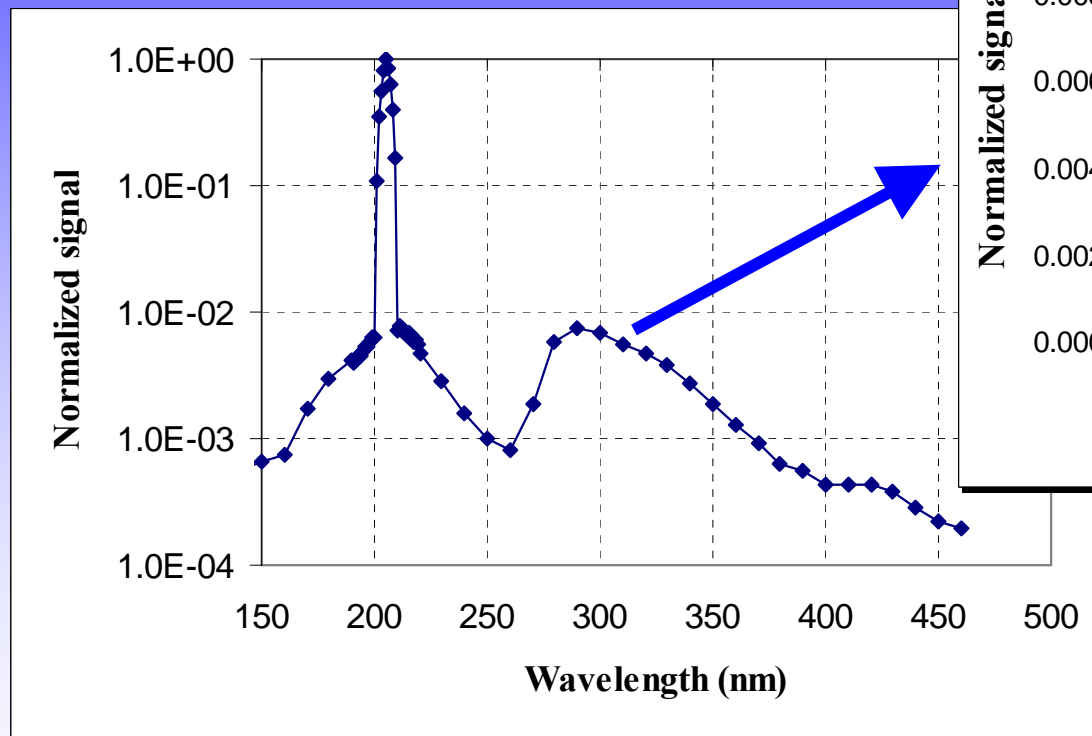
## 2. Relative laser power determination from in-band slit scattering function



Relative laser power  $\Phi^0 = \frac{\int_{in-band} S(\lambda) d\lambda}{R_s(\lambda_0)}$

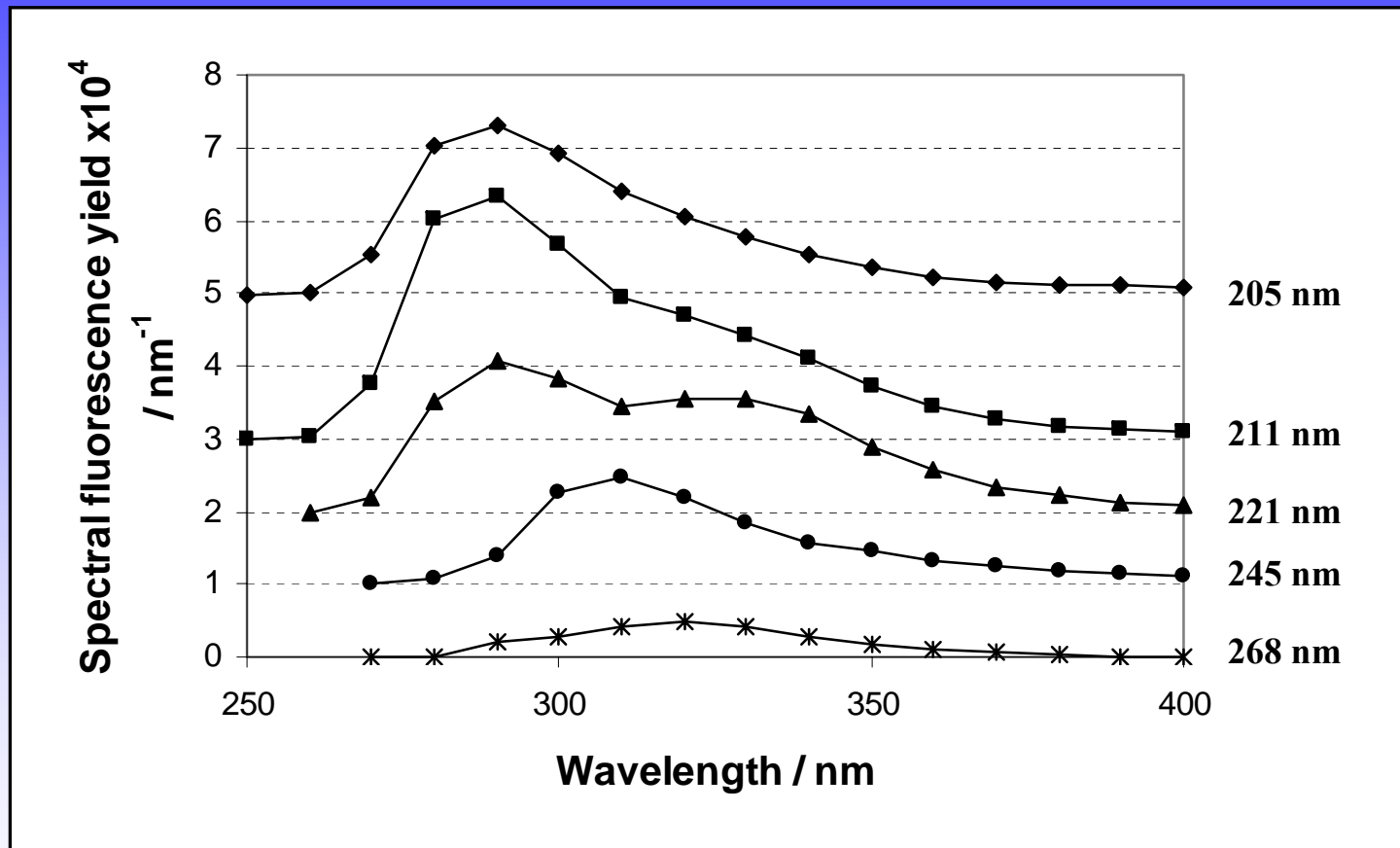
# Measuring total spectral fluorescence yield

## 3. Relative spectral fluorescence power determination



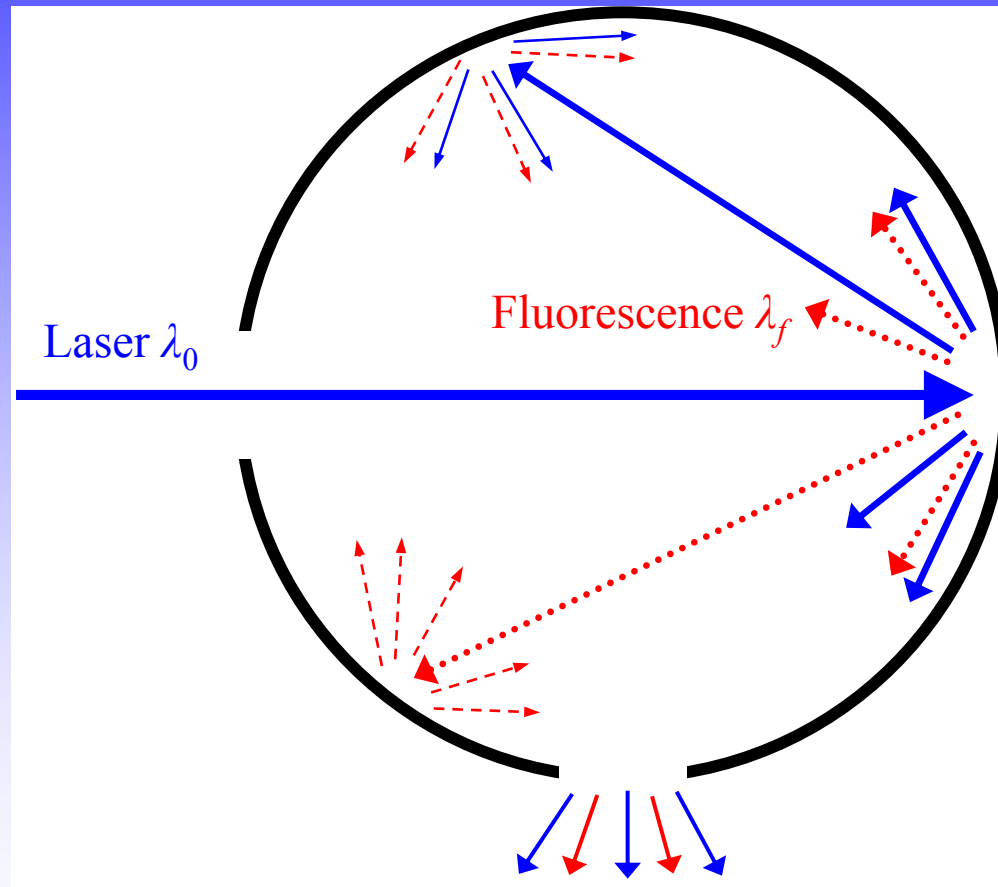
$$\text{Spectral fluorescence yield } f_{\lambda, total}(\lambda, \lambda_0) = \frac{[S(\lambda) - S_{bg}(\lambda)]}{R_s(\lambda)} \bigg/ \frac{\int_{in-band} S(\lambda_i) d\lambda_i}{R_s(\lambda_0)}$$

# Total spectral fluorescence yield of an integrating sphere



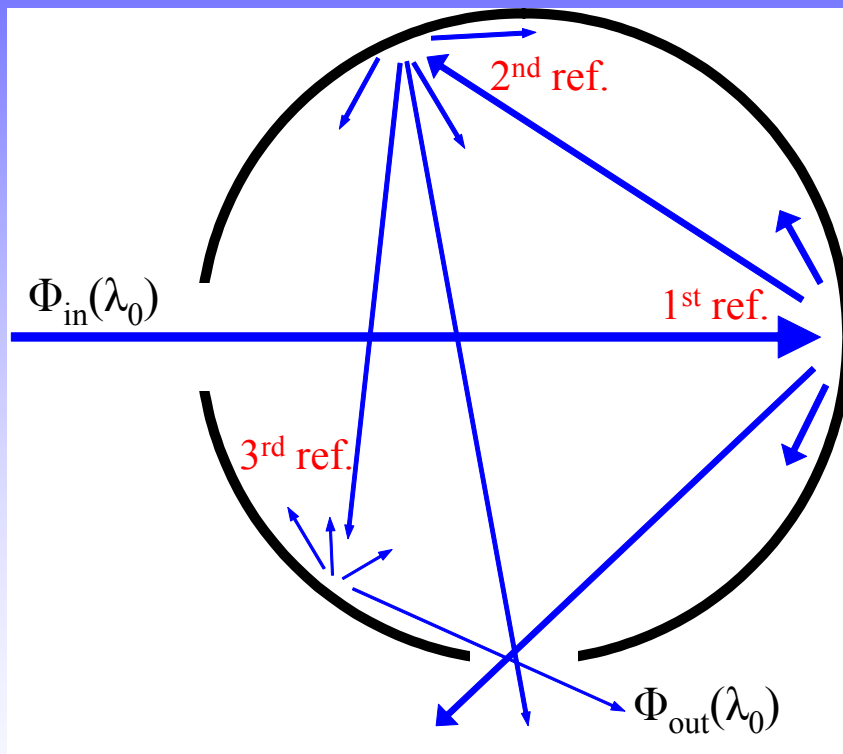
P.S. Shaw U. Arp and K.R. Lykke, to be published in Metrologia

# Theory of fluorescence from integrating spheres



P.S. Shaw and Z. Li, Applied Optics, Vol. 47, page 3962 (2008)

## Basic integrating sphere throughput formula



Throughput of an integrating sphere can be calculated by summing contribution from all reflections inside the sphere as

$$\frac{\Phi_{out}(\lambda_0)}{\Phi_{in}(\lambda_0)} = \frac{\rho(\lambda_0)\alpha A_r}{1 - \rho(\lambda_0)(1 - A_r)}$$

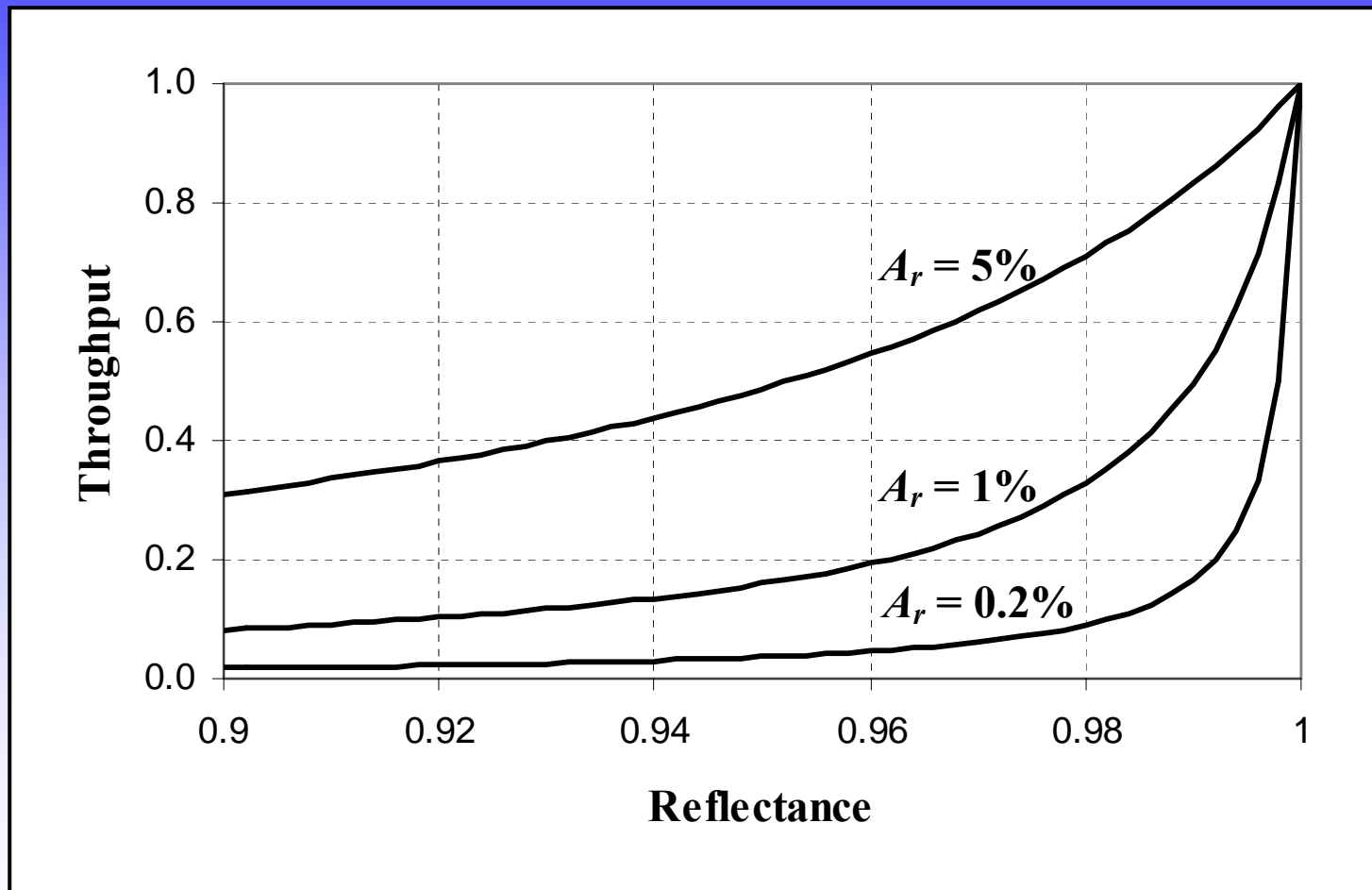
$A_r$  : total port area

$\alpha$  : exit port area / total port area

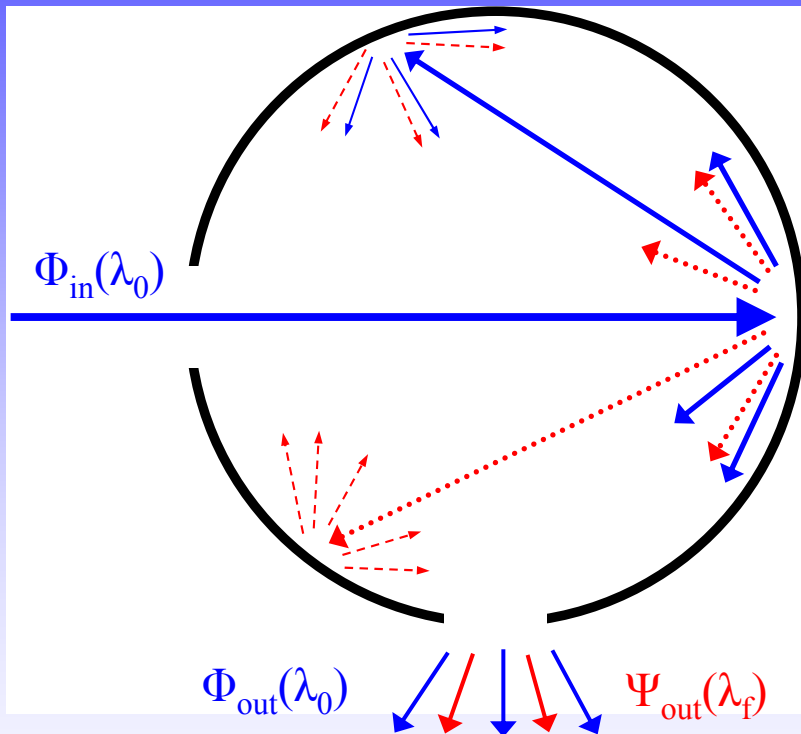
$\rho(\lambda)$  : diffuse reflectance of the inner coating in hemispherical illumination geometry.



# Calculated integrating sphere throughput as a function of reflectance



## Calculation of the fluorescence excited by multiple reflection of the incident radiation



By summing fluorescence from all reflections inside the sphere, the fluorescence yield is

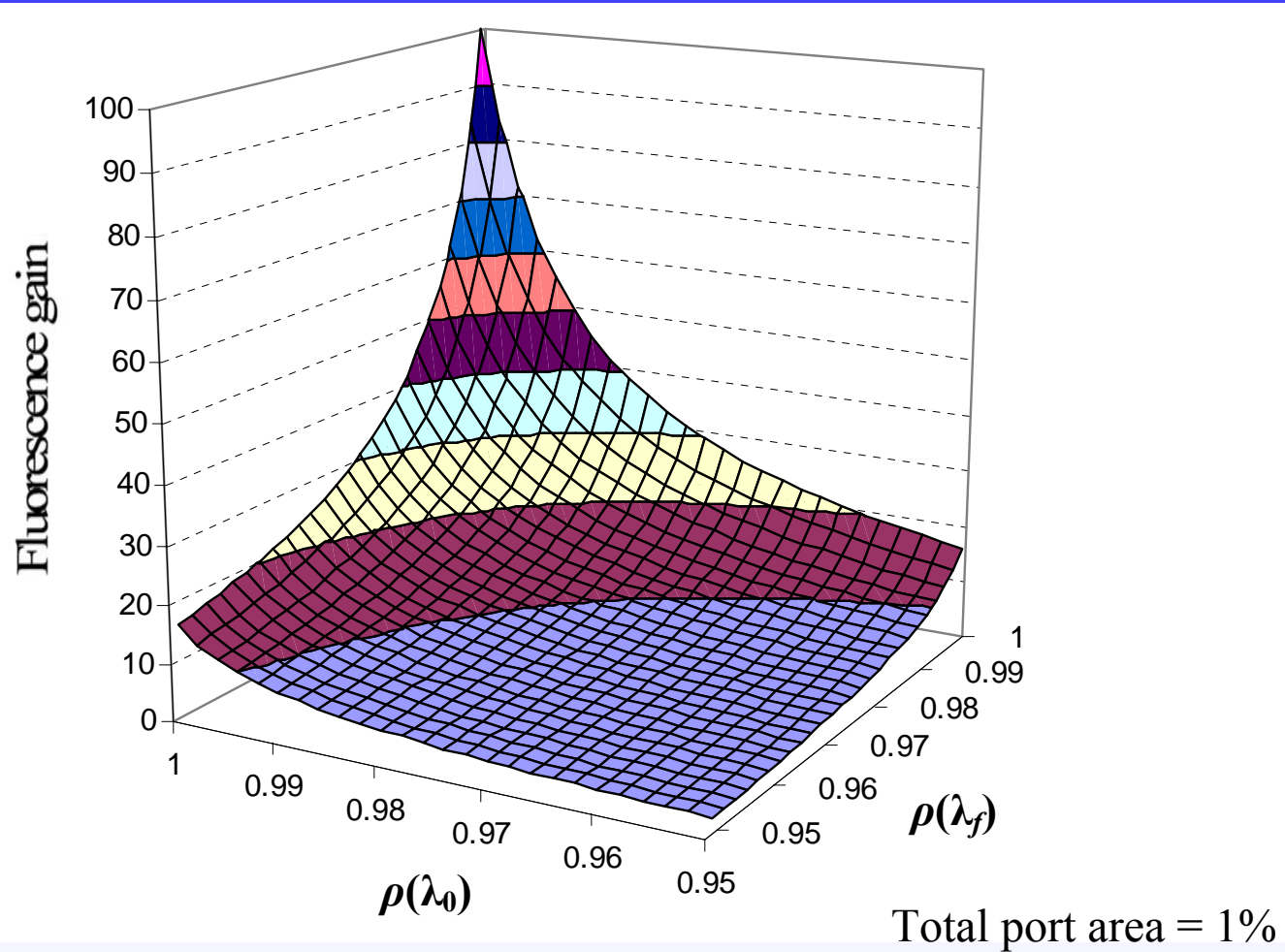
$$\frac{\Psi_{out}(\lambda_f)}{\Phi_{in}(\lambda_0)} = f(\lambda_f, \lambda_0) \frac{\rho(\lambda_f)\alpha A_r}{[(1 - \rho(\lambda_f)(1 - A_r))][1 - \rho(\lambda_0)(1 - A_r)]}$$

$f(\lambda_f, \lambda_0)$  : fluorescence yield at  $\lambda_f$  for a plaque excited by  $\lambda_0$ .

Define a fluorescence gain factor,  $\kappa$ , as the ratio of the fluorescence emerging from an integrating sphere to that of a flat sample excited by the same incident beam.

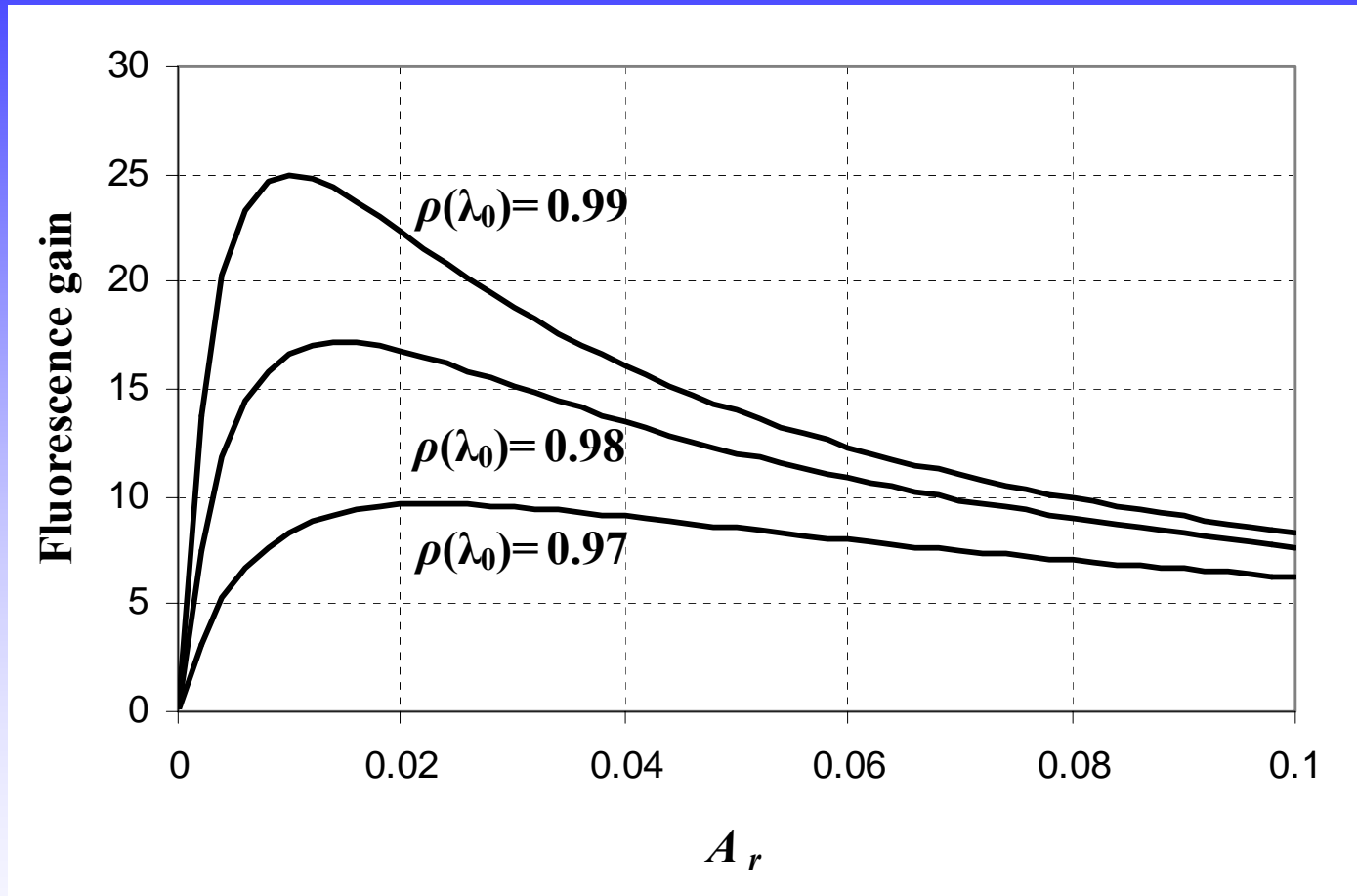
$$\kappa = \frac{\rho(\lambda_f)\alpha A_r}{[(1 - \rho(\lambda_f)(1 - A_r))][1 - \rho(\lambda_0)(1 - A_r)]}$$

# Calculated fluorescence gain of an integrating sphere

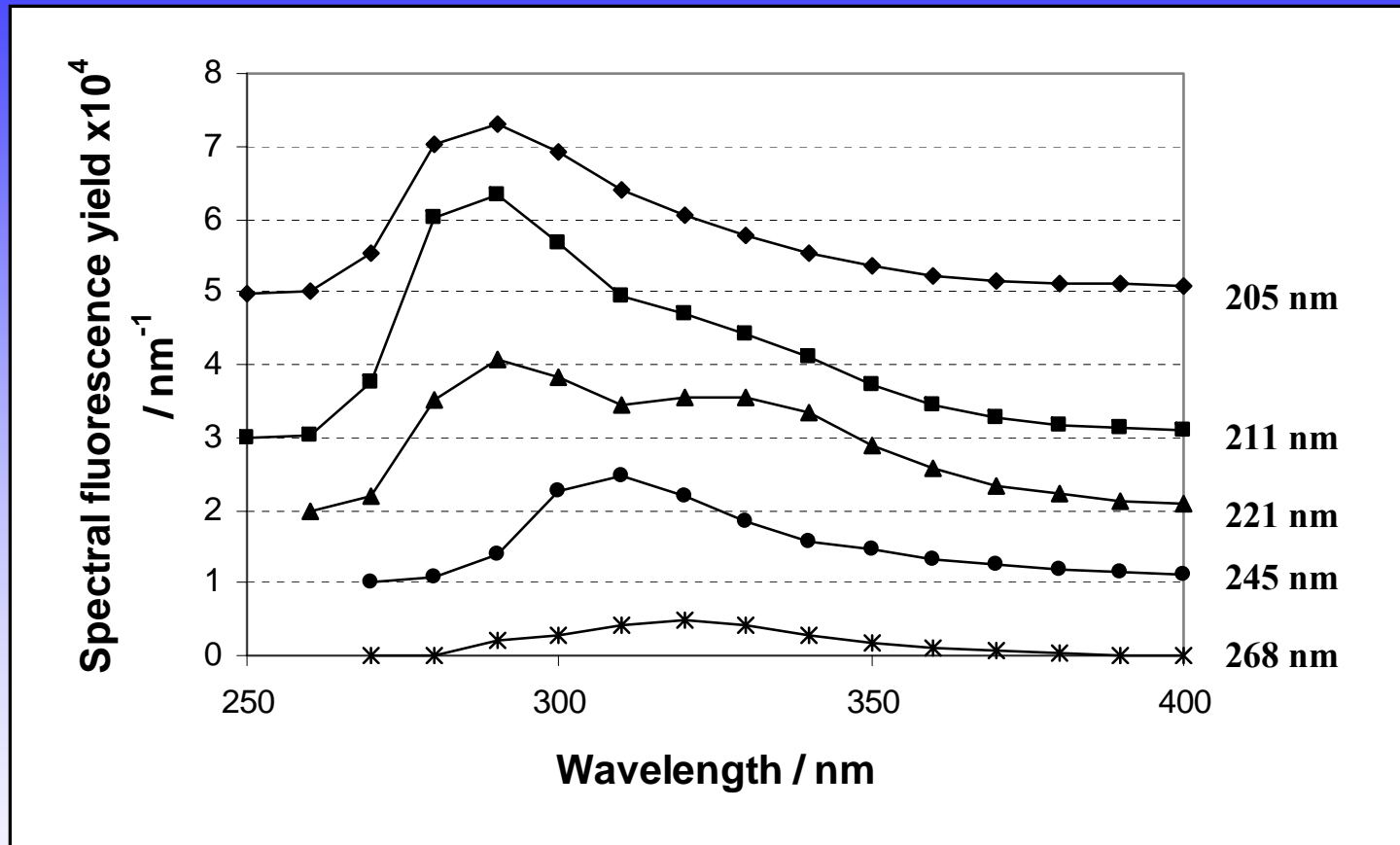


High fluorescence gain of an integrating sphere caused by multiple reflection of exciting radiation

# Calculated fluorescence gain as a function of port area



# Theoretical expression for the measured total spectral fluorescence yield of an integrating sphere



Total spectral fluorescence yield  $f_{\lambda, total}(\lambda_f, \lambda_0) = f(\lambda_f, \lambda_0) \frac{1}{[1 - \rho(\lambda_0)(1 - A_r)]}$

## Conclusion

- Integrating sphere fluorescence is mainly caused by contamination of the wall coating.
- Total fluorescence yield of an integrating sphere can be derived from the measurement result of laser induced fluorescence.
- Integrating sphere fluorescence has been modeled theoretically.
- Fluorescence from an integrating sphere is enhanced because of multiple reflection of the incident beam.
- Integrating spheres can potentially be used as sensitive contamination detection devices.